

Verykool USA Inc

Mobile phone

Main Model: s4510

Serial Model: N/A

July 18, 2014

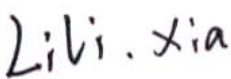


Report No.: 14070326-FCC-E1

(This report supersedes NONE)



Modifications made to the product : None

This Test Report is Issued Under the Authority of:

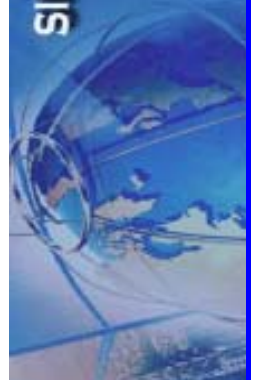
		
Lili Xia Compliance Engineer	Alex Liu Technical Manager	

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Test result presented in this test report is applicable to the representative sample only.

EMC Test Report

To: FCC Part 15 Subpart B Class B: 2013, ANSI C63.4: 2009

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Country/Region	Scope
USA	EMC , RF/Wireless , Telecom
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Taiwan	EMC, RF, Telecom , Safety
Hong Kong	RF/Wireless ,Telecom
Australia	EMC, RF, Telecom , Safety
Korea	EMI, EMS, RF , Telecom, Safety
Japan	EMI, RF/Wireless, Telecom
Singapore	EMC , RF , Telecom
Europe	EMC, RF, Telecom , Safety



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Serial Model: N/A
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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 3 of 36
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CONTENTS

1 EXECUTIVE SUMMARY & EUT INFORMATION	5
2 TECHNICAL DETAILS.....	6
3 MODIFICATION.....	7
4 TEST SUMMARY.....	8
5 MEASUREMENTS, EXAMINATION AND DERIVED RESULTS.....	9
ANNEX A. TEST INSTRUMENTATION & GENERAL PROCEDURES	14
ANNEX B. EUT AND TEST SETUP PHOTOGRAPHS	19
ANNEX C. TEST SETUP AND SUPPORTING EQUIPMENT.....	31
ANNEX D. USER MANUAL / BLOCK DIAGRAM / SCHEMATICS / PART LIST	35
ANNEX E. DECLARATION OF SIMILARITY	36



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Title: EMC Test Report for Mobile phone
Main Model: s4510
Serial Model: N/A
To: FCC Part 15 Subpart B Class B: 2013 , ANSI C63.4:2009

Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 5 of 36
www.siemic.com
www.siemic.com.cn

1 EXECUTIVE SUMMARY & EUT INFORMATION

The purpose of this test programme was to demonstrate compliance of the Verykool USA Inc, Mobile phone and Model: s4510 against the current Stipulated Standards. The Mobile phone has demonstrated compliance with the FCC Part 15 Subpart B Class B: 2013, ANSI C63.4: 2009.

EUT Information

EUT Description : Mobile phone

Main Model : s4510

Serial Model : N/A

Antenna Gain : AWS1700: -2.5 dBi
GSM850/ UMTS-FDD Band V: -2 dBi
PCS1900/UMTS-FDD Band II: -2.5 dBi
Bluetooth: 0 dBi
WIFI: 0 dBi

Input Power : Battery:
Model: Ar715144
Spec: 3.7V 1650mAh
Limited charger voltage: 4.2V
Adapter:
Model: UC26A50100
Input: AC 100-240V; 50/60Hz 150mA
Output: DC 5.0V; 1A

Classification Per Stipulated Test Standard : Class B Emission Product Per
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4: 2009



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Serial Model: N/A
To: FCC Part 15 Subpart B Class B: 2013 , ANSI C63.4:2009

Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 6 of 36
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2 TECHNICAL DETAILS

Purpose	Compliance testing of Mobile phone with stipulated standards
Applicant / Client	Verykool USA Inc 3636 Nobel Drive, Suite 325, San Diego, CA 92122 USA
Manufacturer	ZTE Supply Chain Co.,Ltd. 6/F, South Wing, WanDeLai Building, Keji Road South, Hi-Tech Park, Nanshan District, Shenzhen, P.R.China, 518057
Laboratory performing the tests	SIEMIC (Shenzhen-China) Laboratories Zone A, Floor 1, Building 2, Wan Ye Long Technology Park, South Side of Zhoushi Road, Bao'an District, Shenzhen, Guangdong, China Tel: +86-0755-2601 4629 / 2601 4953 Fax: +86-0755-2601 4953-810 Email: China@siemic.com.cn
Test report reference number	14070326-FCC-E1
Date EUT received	June 23, 2014
Standard applied	FCC Part 15 Subpart B Class B: 2013, ANSI C63.4: 2009
Dates of test	July 01 to July 02, 2014
No of Units	#1
Equipment Category	JBP
Trade Name	verykool
RF Operating Frequency (ies)	GSM850 TX : 824.2 ~ 848.8 MHz; RX : 869.2 ~ 893.8 MHz PCS1900 TX : 1850.2 ~ 1909.8 MHz; RX : 1930.2 ~ 1989.8 MHz UMTS-FDD Band V TX : 826.4 ~ 846.6 MHz; RX : 871.4 ~ 891.6 MHz UMTS-FDD Band II TX : 1852.4 ~ 1907.6 MHz; RX : 1932.4 ~ 1987.6 MHz UMTS-FDD Band IV TX : 1712.4 ~ 1752.6 MHz; RX : 2112.4 ~ 2152.6 MHz 802.11b/g/n: 2412-2462 MHz Bluetooth: 2402-2480 MHz
Number of Channels	299CH (PCS1900) and 124CH (GSM850) UMTS-FDD Band V : 102CH UMTS-FDD Band II : 277CH UMTS-FDD Band IV: 202CH Bluetooth: 79CH 802.11b/g/n: 11CH
Modulation	GSM / GPRS: GMSK UMTS-FDD: QPSK UMTS-FDD: QPSK 802.11b/g/n: DSSS/OFDM Bluetooth: GFSK& $\pi/4$DQPSK&8DPSK
GPRS Multi-slot class	8/10/12
FCC ID	WA6S4510



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To: FCC Part 15 Subpart B Class B: 2013 , ANSI C63.4:2009

Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 7 of 36
www.siemic.com
www.siemic.com.cn

3 MODIFICATION

NONE

4 TEST SUMMARY

The product was tested in accordance with the following specifications.
 All testing has been performed according to below product classification:

Class B Emission Product

Test Results Summary

Emissions			
Test Standard	Description	Product Class	Pass / Fail
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4: 2009	Conducted Emissions	See Above	Pass
FCC Part 15 Subpart B Class B: 2013, ANSI C63.4: 2009	Radiated Emissions	See Above	Pass

All measurement uncertainty is not taken into consideration for all presented test result.



5 MEASUREMENTS, EXAMINATION AND DERIVED RESULTS

5.1 Conducted Emissions Test Result

Note:

1. All possible modes of operation were investigated. Only the several worst case emissions measured, using the correct CISPR and Average detectors, are reported. All other emissions were relatively insignificant.
2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
3. Conducted Emissions Measurement Uncertainty
All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 9kHz – 30MHz (Average & Quasi-peak) is $\pm 3.86\text{dB}$.
4. Environmental Conditions

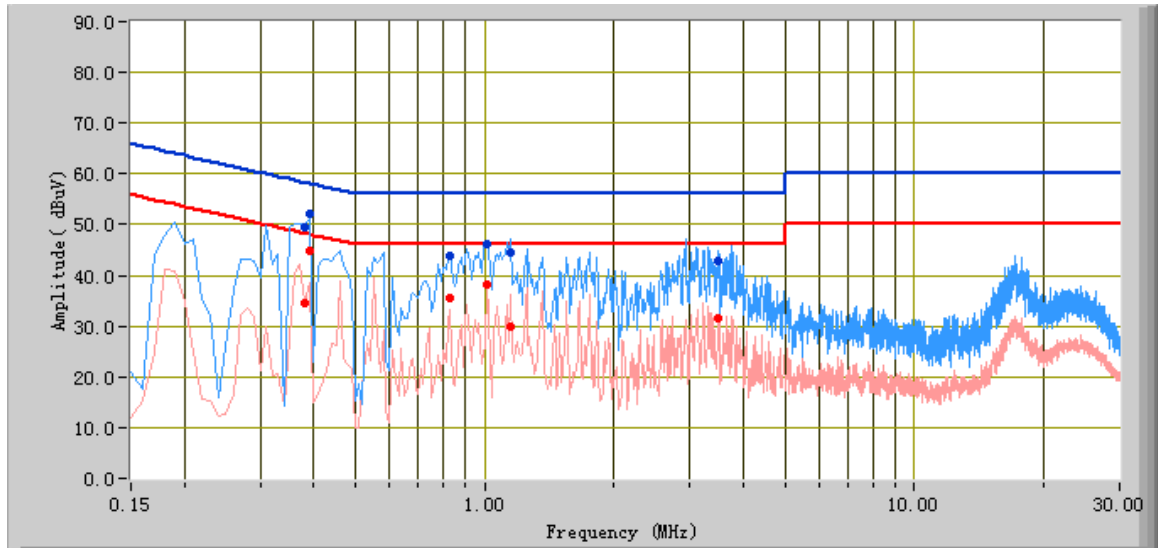
Temperature	24°C
Relative Humidity	53%
Atmospheric Pressure	1018mbar
5. Test date : July 01, 2014
Tested By : Lili Xia

Test Result: Pass



Test Mode: Charging & Downloading

Peak Detector **Quasi Peak Limit**
Average Detector **Average Limit**



Test Data

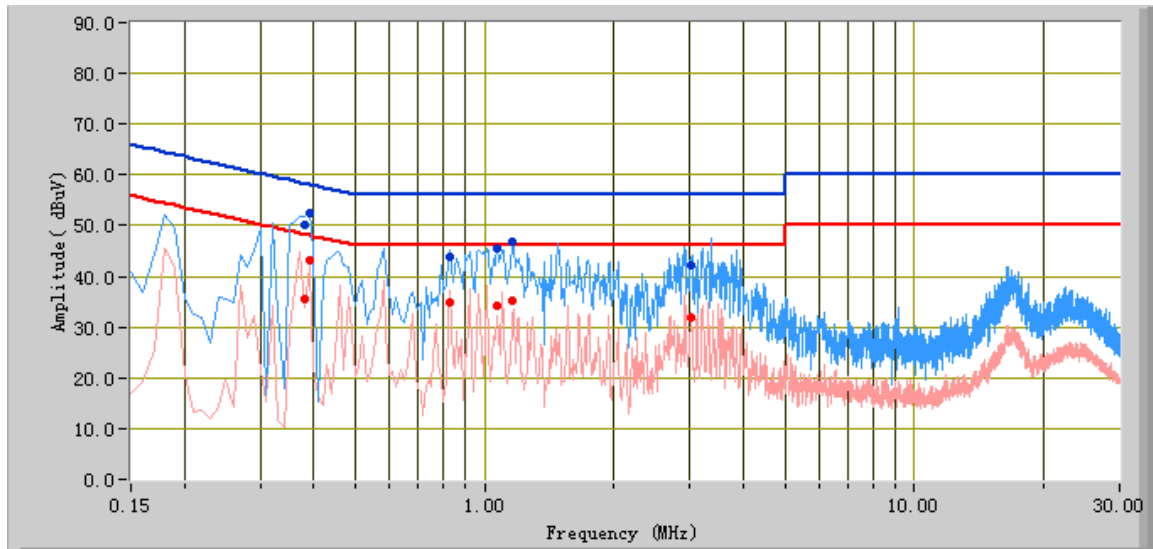
Phase Line Plot at 120V AC, 60Hz

Frequency (MHz)	Quasi Peak (dBuV)	Limit (dBuV)	Margin (dB)	Average (dBuV)	Limit (dBuV)	Margin (dB)	Factors (dB)
0.39	52.24	58.06	-5.82	44.84	48.06	-3.22	11.03
0.38	49.41	58.28	-8.87	34.52	48.28	-13.76	11.08
1.15	44.60	56.00	-11.40	29.94	46.00	-16.06	10.29
1.01	46.15	56.00	-9.85	38.29	46.00	-7.71	10.29
3.50	42.89	56.00	-13.11	31.70	46.00	-14.30	10.71
0.83	43.98	56.00	-12.02	35.70	46.00	-10.30	10.38



Test Mode: Charging & Downloading

Peak Detector Quasi Peak Limit Average Detector Average Limit



Test Data



Phase Natural Plot at 120V AC, 60Hz

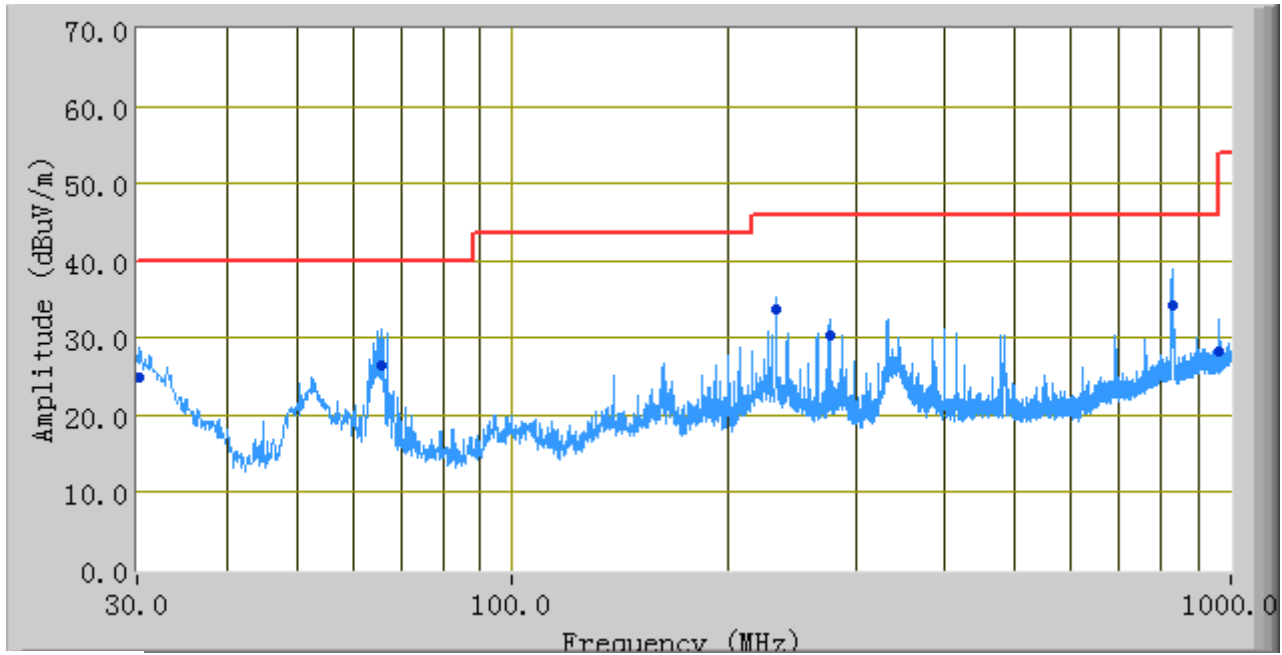
Frequency (MHz)	Quasi Peak (dBuV)	Limit (dBuV)	Margin (dB)	Average (dBuV)	Limit (dBuV)	Margin (dB)	Factors (dB)
0.39	52.55	58.06	-5.51	43.06	48.06	-5.00	11.03
0.38	50.03	58.28	-8.25	35.42	48.28	-12.86	11.08
1.16	46.70	56.00	-9.30	35.29	46.00	-10.71	10.29
1.07	45.52	56.00	-10.48	34.30	46.00	-11.70	10.28
0.83	43.90	56.00	-12.10	34.85	46.00	-11.15	10.38
3.02	42.02	56.00	-13.98	31.83	46.00	-14.17	10.63



Test Mode:	Charging & Downloading
-------------------	-----------------------------------

Below 1GHz

Peak Detector 
 Quasi Peak Limit 



Test Data

Frequency (MHz)	Quasi Peak (dBuV/m)	Azimuth	Polarity(H/V)	Height (cm)	Factors (dB)	Limit (dBuV)	Margin (dB)
828.89	34.30	219.00	V	209.00	3.86	46.00	-11.70
65.58	26.54	51.00	V	152.00	-13.78	40.00	-13.46
232.35	33.83	93.00	H	147.00	-7.65	46.00	-12.17
30.12	24.80	0.00	V	132.00	-1.77	40.00	-15.20
959.94	28.32	254.00	H	165.00	5.72	46.00	-17.68
276.04	30.25	239.00	H	102.00	-7.02	46.00	-15.75

Note: The data above 1 GHz which below 20 dB to the limit was not recorded.



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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 14 of 36
www.siemic.com
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Annex A. TEST INSTRUMENTATION & GENERAL PROCEDURES

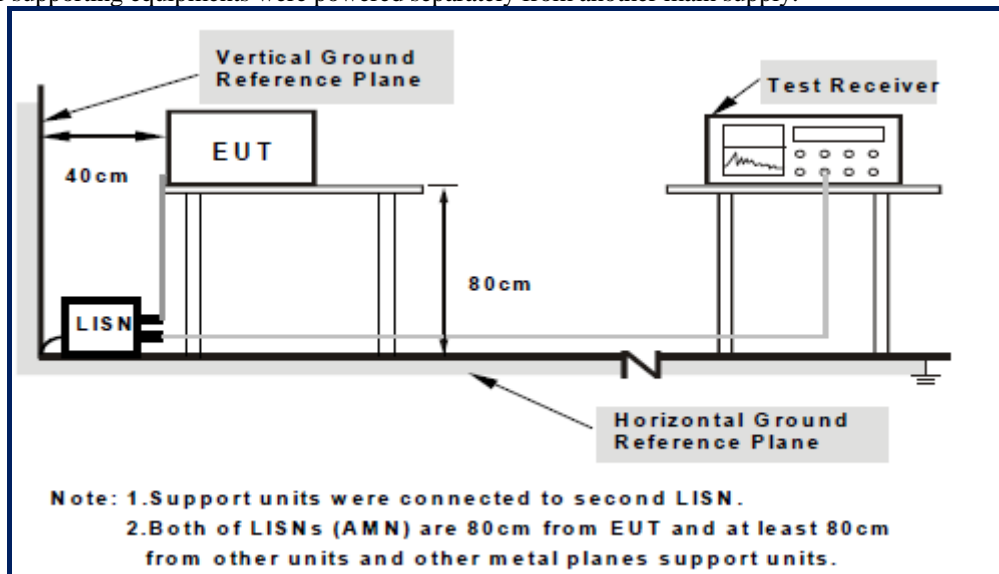
Annex A.i. TEST INSTRUMENTATION

Instrument	Model	Serial #	Calibration Date	Calibration Due Date
AC Line Conducted Emissions				
EMI test receiver	ESCS30	8471241027	05/27/2014	05/26/2015
Line Impedance Stabilization Network	LI-125A	191106	11/14/2013	11/13/2014
Line Impedance Stabilization Network	LI-125A	191107	11/14/2013	11/13/2014
LISN	ISN T800	34373	01/11/2014	01/10/2015
Transient Limiter	LIT-153	531118	09/02/2013	09/01/2014
Radiated Emissions				
EMI test receiver	ESL6	100262	11/23/2013	11/22/2014
OPT 010 AMPLIFIER (0.1-1300MHz)	8447E	2727A02430	09/02/2013	09/01/2014
Microwave Preamplifier (0.5~18GHz)	PAM-118	443008	09/02/2013	09/01/2014
Bilog Antenna (30MHz~6GHz)	JB6	A110712	09/23/2013	09/22/2014
Double Ridge Horn Antenna	AH-118	71259	11/20/2013	11/19/2014

Annex A.ii. AC LINE CONDUCTED EMISSIONS TEST DESCRIPTION

Test Set-up

1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m x 1m x 0.8m high, non-metallic table, as shown in Annex B.
2. The power supply for the EUT was fed through a 50Ω/50μH EUT LISN, connected to filtered mains.
3. The RF OUT of the EUT LISN was connected to the EMI test receiver via a low-loss coaxial cable.
4. All other supporting equipments were powered separately from another main supply.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration1

Test Method

1. The EUT was switched on and allowed to warm up to its normal operating condition.
2. A scan was made on the NEUTRAL line (for AC mains) or Earth line (for DC power) over the required frequency range using an EMI test receiver.
3. High peaks, relative to the limit line, were then selected.
4. The EMI test receiver was then tuned to the selected frequencies and the necessary measurements made with a receiver bandwidth setting of 10 kHz. For FCC tests, only Quasi-peak measurements were made; while for CISPR/EN tests, both Quasi-peak and Average measurements were made.
5. Steps 2 to 4 were then repeated for the LIVE line (for AC mains) or DC line (for DC power).

Description of Conducted Emission Program

This EMC Measurement software run LabView automation software and offers a common user interface for electromagnetic interference (EMI) measurements. This software is a modern and powerful tool for controlling and monitoring EMI test receivers and EMC test systems. It guarantees reliable collection, evaluation, and documentation of measurement results. Basically, this program will run a pre-scan measurement before it proceeds with the final measurement. The pre-scan routine will run the common scan range from 150 kHz to 30 MHz; the program will first start a peak and average scan on selectable measurement time and step size. After the program complete the pre-scan, this program will perform the Quasi Peak and Average measurement, based on the pre-scan peak data reduction result.



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Serial Model: N/A
To: FCC Part 15 Subpart B Class B: 2013 , ANSI C63.4:2009

Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 16 of 36
www.siemic.com
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Sample Calculation Example

At 20 MHz

limit = $250 \mu\text{V} = 47.96 \text{ dB}\mu\text{V}$

Transducer factor of LISN, pulse limiter & cable loss at 20 MHz = 11.20 dB

Q-P reading obtained directly from EMI Receiver = 40.00 dB μV
(Calibrated for system losses)

Therefore, Q-P margin = $47.96 - 40.00 = 7.96$ i.e. **7.96 dB below limit**

Annex A. iii. RADIATED EMISSIONS TEST DESCRIPTION

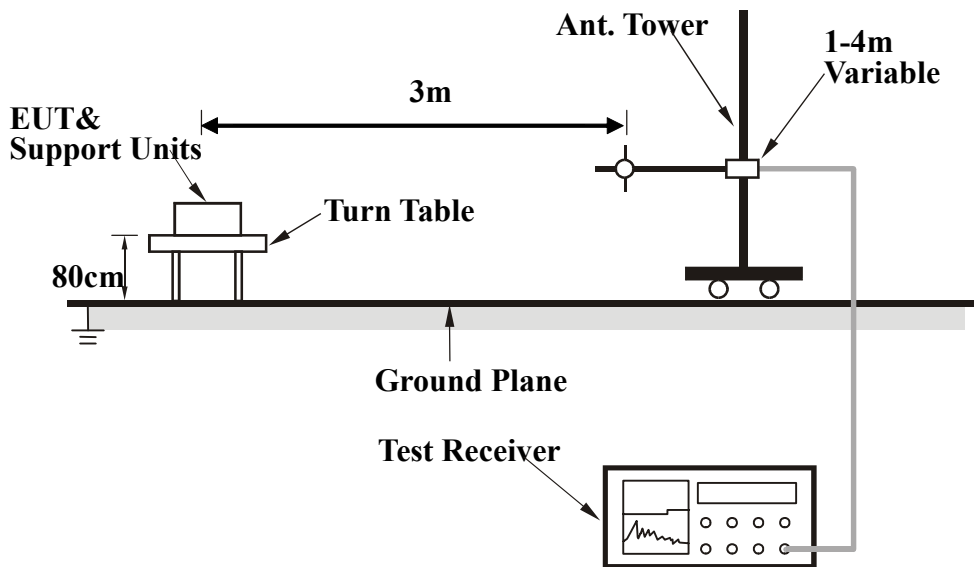
EUT Characterisation

EUT characterisation, over the frequency range from 30MHz to 10th Harmonic, was done in order to minimise radiated emissions testing time while still maintaining high confidence in the test results.

The EUT was placed in the chamber, at a height of about 0.8 m on a turntable. Its radiated emissions frequency profile was observed, using a spectrum analyzer /receiver with the appropriate broadband antenna placed 3m away from the EUT. Radiated emissions from the EUT were maximised by rotating the turntable manually, changing the antenna polarisation and manipulating the EUT cables while observing the frequency profile on the spectrum analyzer / receiver. Frequency points at which maximum emissions occurred; clock frequencies and operating frequencies were then noted for the formal radiated emissions test at the Open Area Test Site (OATS) or 3m EMC chamber.

Test Set-up

1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5mX1.0mX0.8m high, non-conductive table.
2. The filtered power supply for the EUT and supporting equipment were tapped from the appropriate power sockets located on the turntable.
3. The relevant broadband antenna was set at the required test distance away from the EUT and supporting equipment boundary.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration2

Test Method

The following procedure was performed to determine the maximum emission axis of EUT:

1. With the receiving antenna is H polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
2. With the receiving antenna is V polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
3. Compare the results derived from above two steps. So, the axis of maximum emission from EUT was determined and the configuration was used to perform the final measurement.

Final Radiated Emission Measurement

1. Setup the configuration according to figure 1. Turn on EUT and make sure that it is in normal function.
2. For emission frequencies measured below 1GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on an open test site. As the same purpose, for emission frequencies measured above 1GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.
3. For emission frequencies measured below and above 1GHz, set the spectrum analyzer on a 100kHz and 1MHz resolution bandwidth respectively for each frequency measured in step 2.
4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from 0° to 360° with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading.
5. Repeat step 4 until all frequencies need to be measured was complete.
6. Repeat step 5 with search antenna in vertical polarized orientations.

During the radiated emission test, the Spectrum Analyzer was set with the following configurations:

Frequency Band (MHz)	Function	Resolution bandwidth	Video Bandwidth
30 to 1000	Peak	100kHz	100kHz
Above 1000	Peak	1MHz	1MHz
	Average	1MHz	10Hz

Sample Calculation Example

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. For the limit is employed average value, therefore the peak value can be transferred to average value by subtracting the duty factor. The basic equation with a sample calculation is as follows:

$$\text{Peak} = \text{Reading} + \text{Corrected Factor}$$

where

$$\text{Corr. Factor} = \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain (if any)}$$

And the average value is

$$\text{Average} = \text{Peak Value} + \text{Duty Factor or}$$

$$\text{Set RBW} = 1\text{MHz, VBW} = 10\text{Hz.}$$

Note:

If the measured frequencies are fall in the restricted frequency band, the limit employed must be quasi peak value when frequencies are below or equal to 1GHz. And the measuring instrument is set to quasi peak detector function.

Annex B. EUT AND TEST SETUP PHOTOGRAPHS

Annex B.i. Photograph 1: EUT External Photo



Whole Package - Top View



Adapter - Front View



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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 20 of 36
www.siemic.com
www.siemic.com.cn



EUT - Front View



EUT - Rear View



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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 21 of 36
www.siemic.com
www.siemic.com.cn



EUT - Top View



EUT - Bottom View



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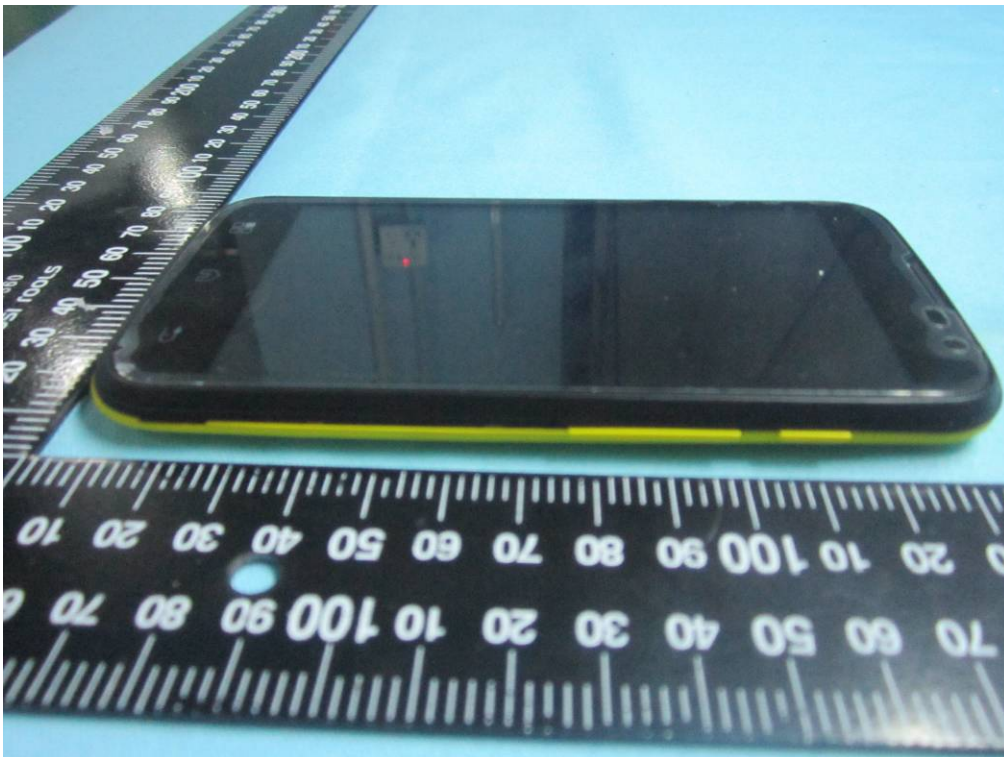
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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 22 of 36
www.siemic.com
www.siemic.com.cn



EUT - Left View



EUT - Right View



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Accessing global markets

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Main Model: s4510
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To: FCC Part 15 Subpart B Class B: 2013 , ANSI C63.4:2009

Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 23 of 36
www.siemic.com
www.siemic.com.cn

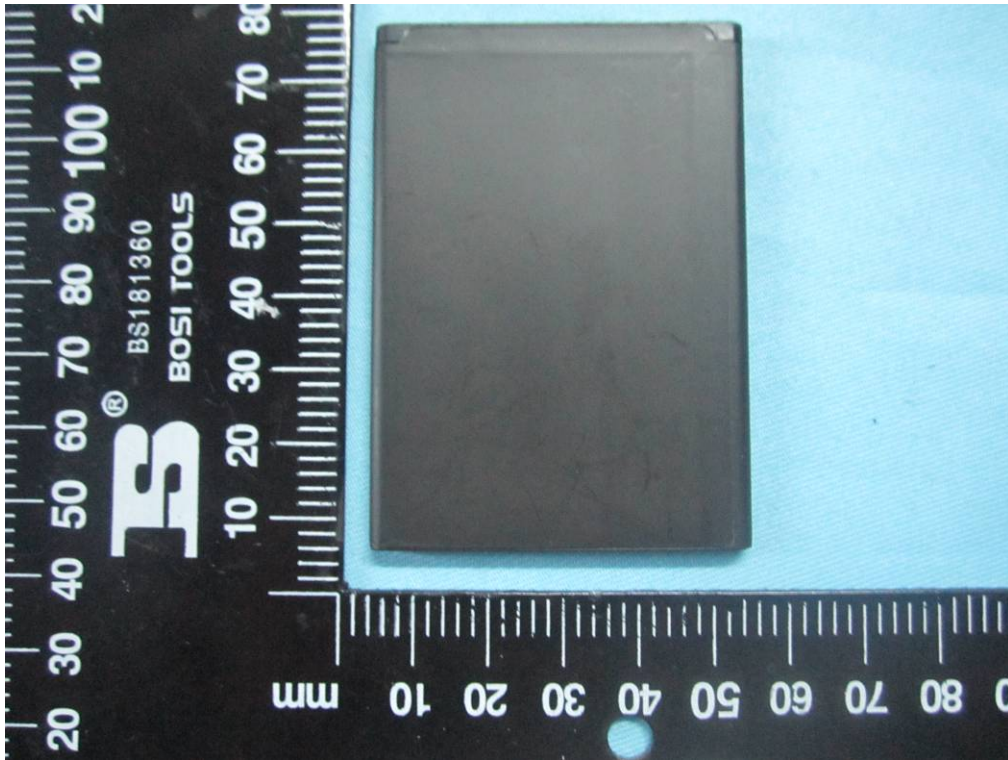
Annex B.ii. Photograph 2: EUT Internal Photo



Cover Off - Top View 1



Cover Off - Top View 2



Battery - Top View



Battery - Bottom View

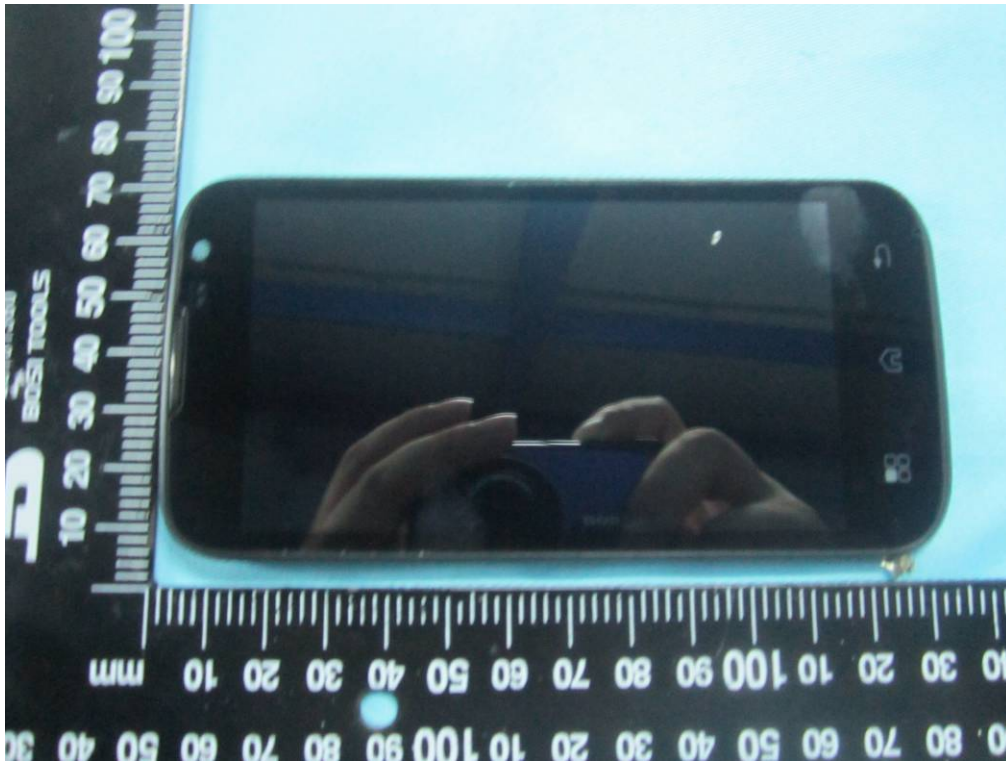


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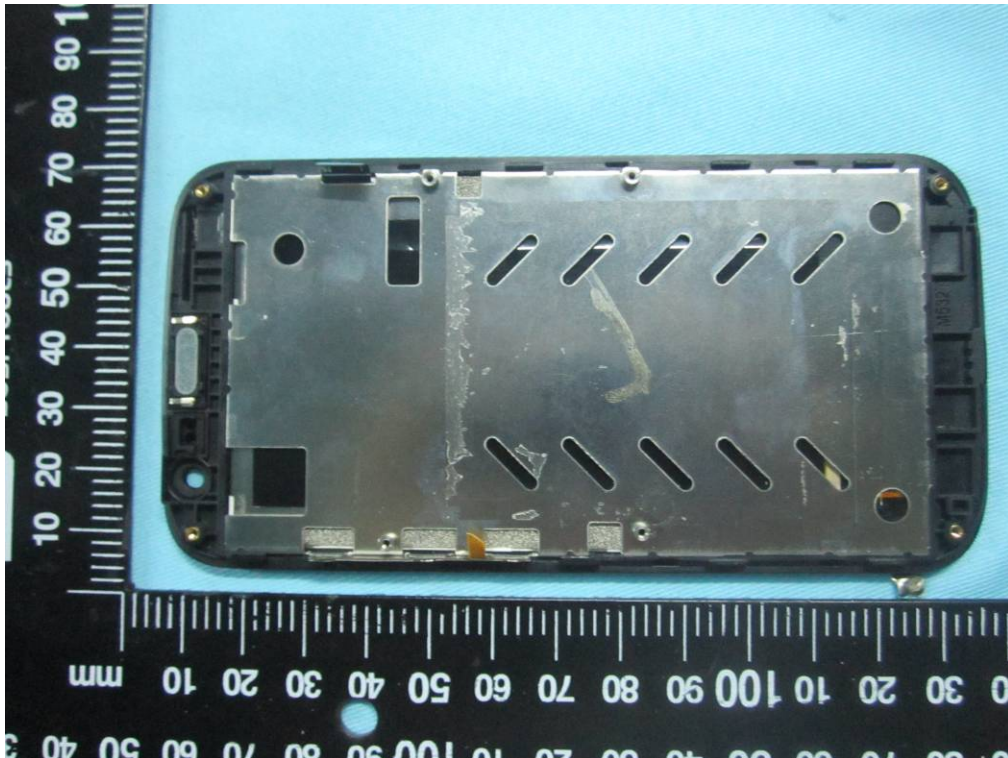
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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 25 of 36
www.siemic.com
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LCD – Front View



LCD – Rear View

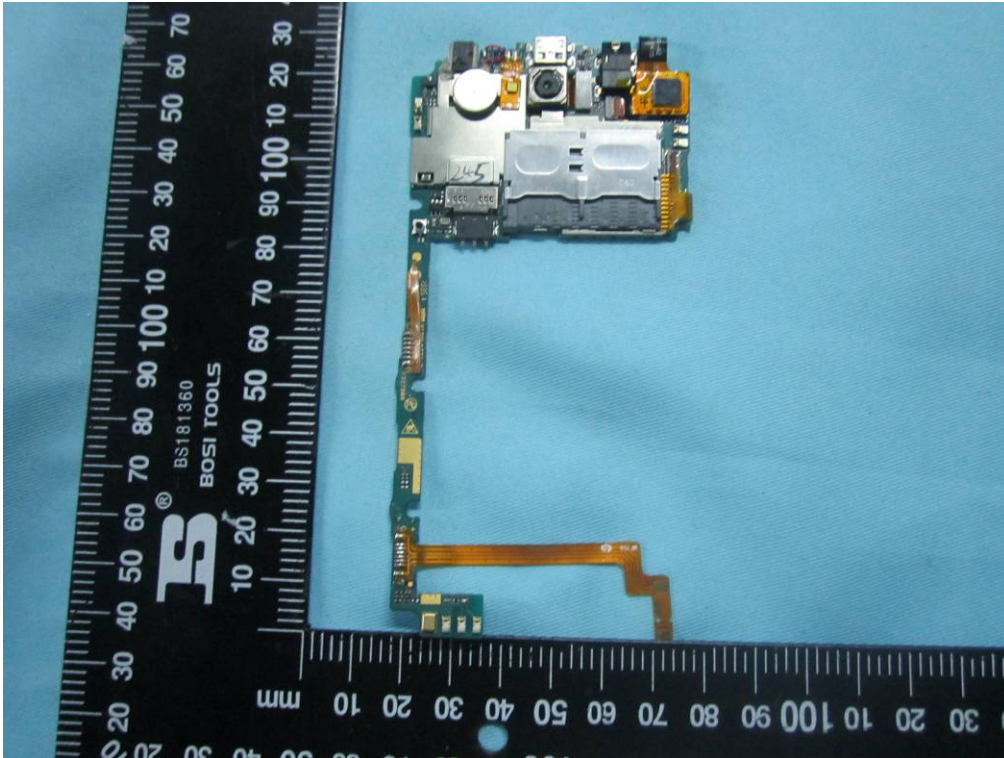


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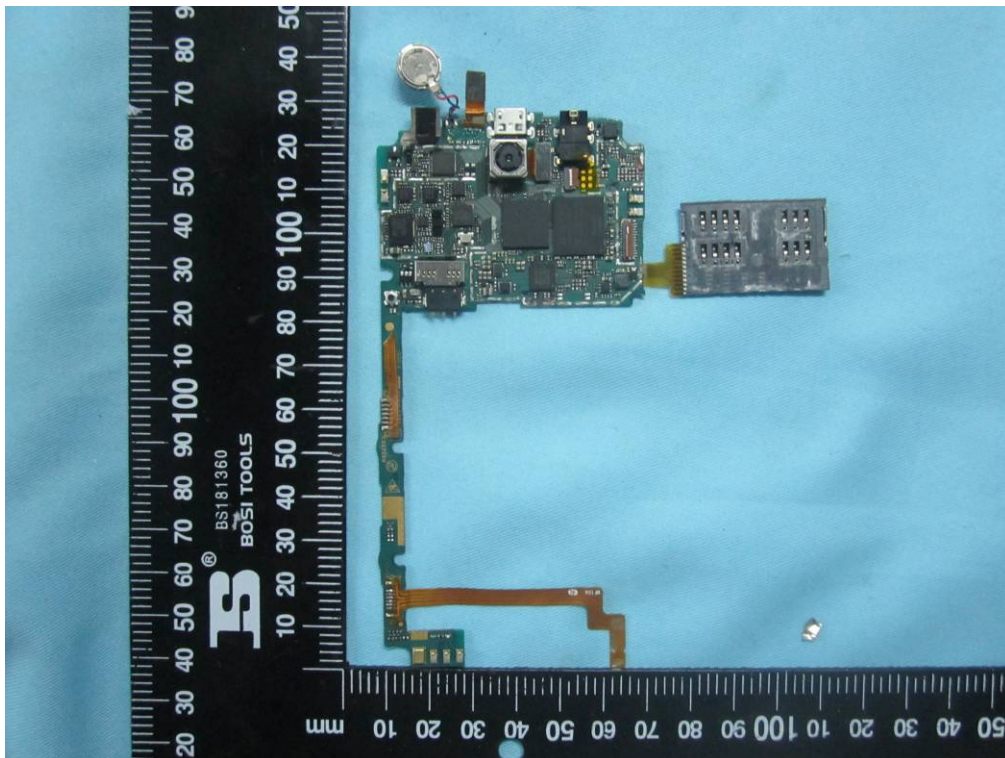
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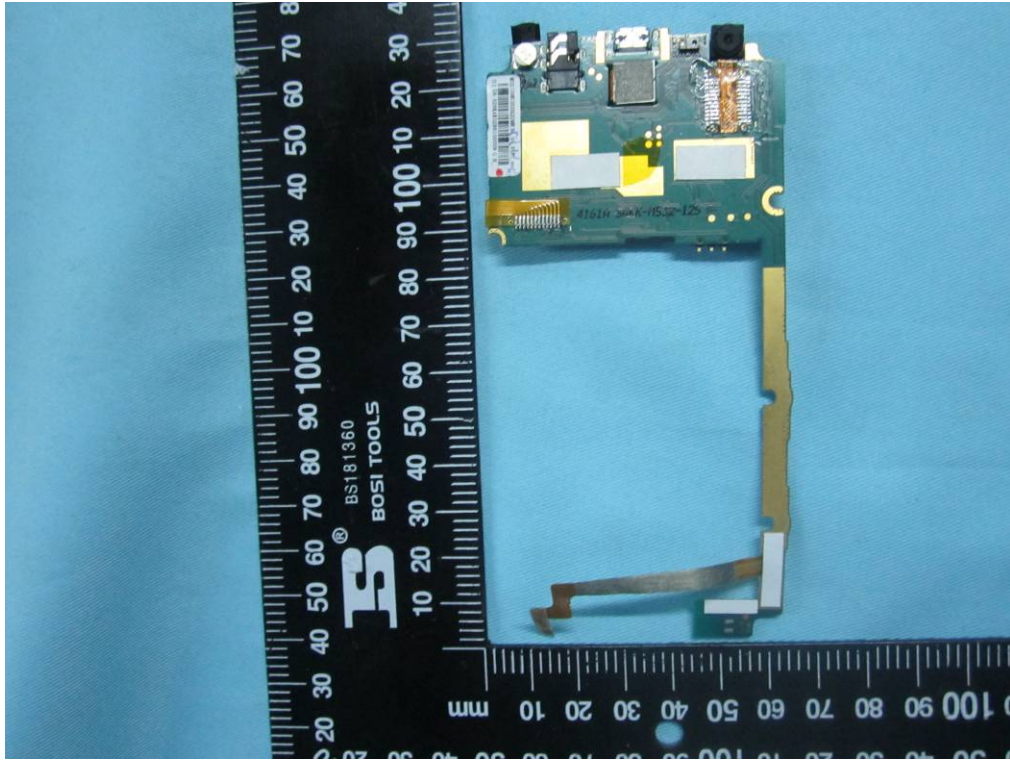
Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 26 of 36
www.siemic.com
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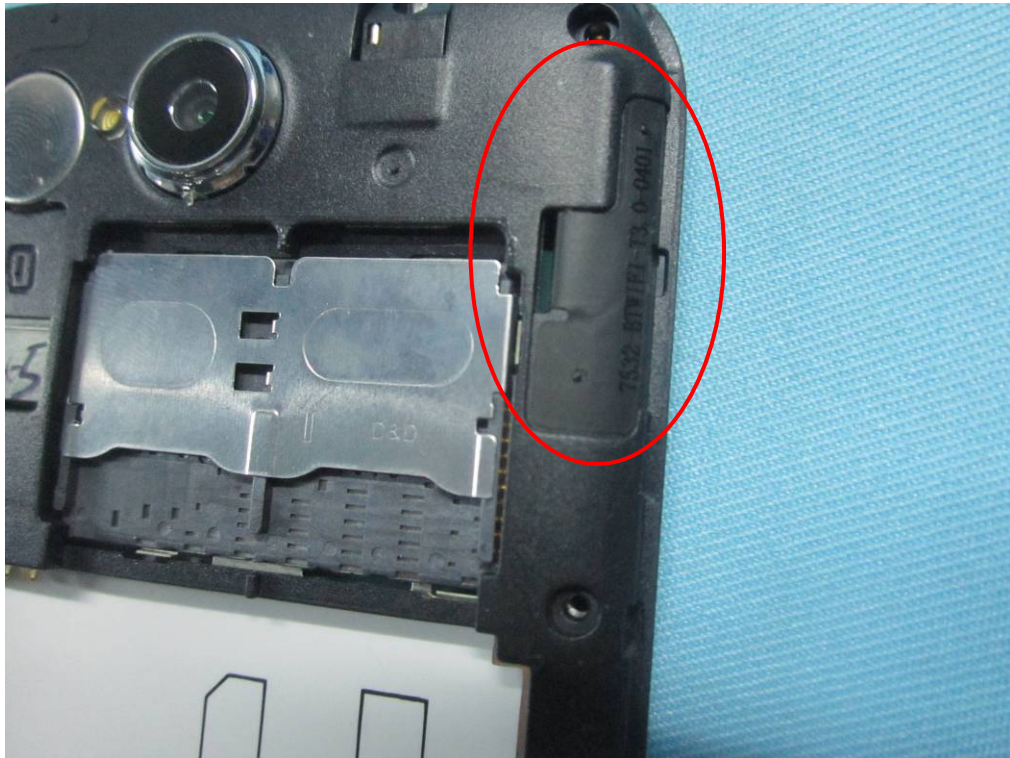
Mainboard With Shielding - Front View



Mainboard Without Shielding - Front View



Mainboard- Rear View



BT/WIFI Antenna View

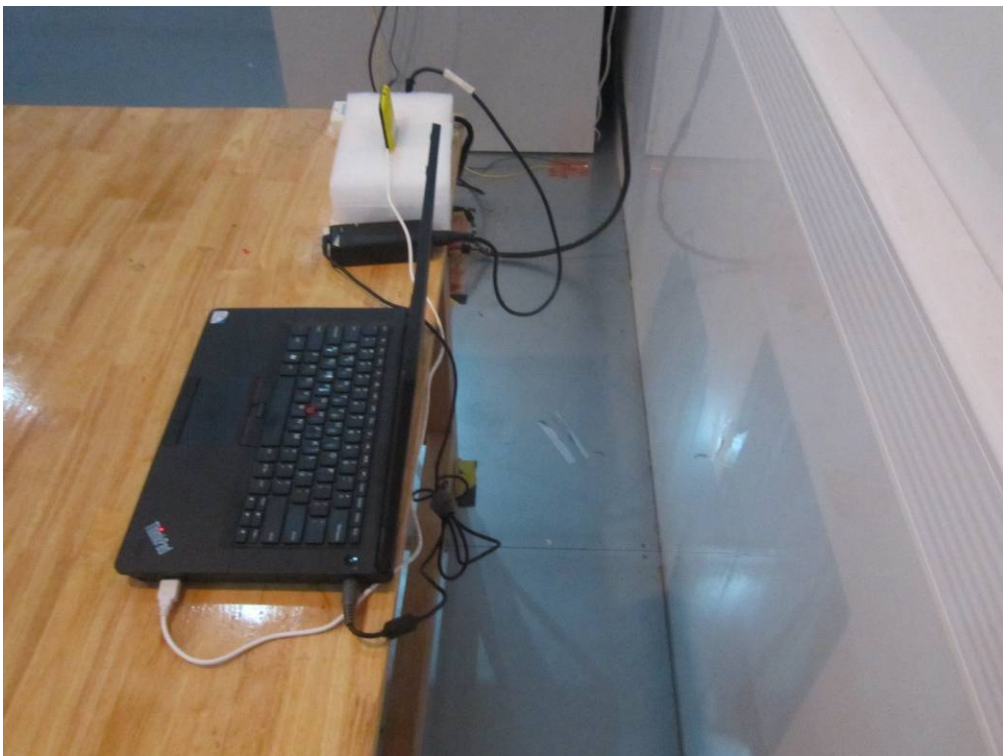


GSM/PCS/UMTS-FDD Antenna View

Annex B.iii. Photograph 3: Test Setup Photo



Conducted Emissions Test Setup Front View



Conducted Emissions Test Setup Side View

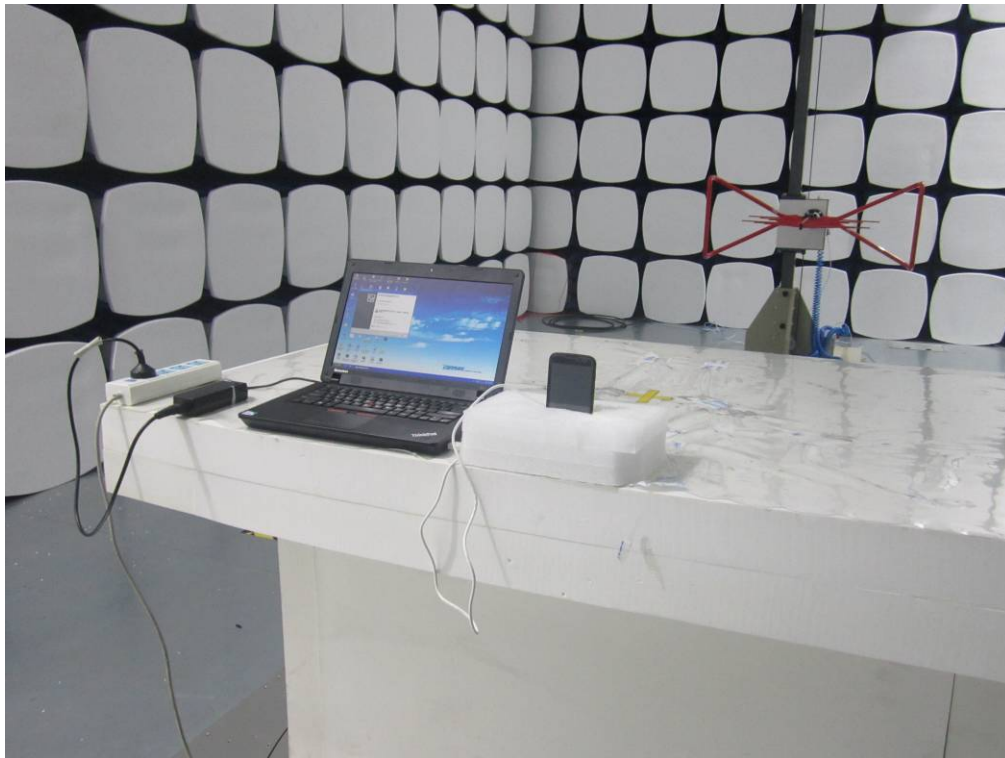


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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 30 of 36
www.siemic.com
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Radiated Spurious Emissions Test Setup Below 1GHz - Front View



Radiated Spurious Emissions Test Setup Above 1GHz –Front View



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Serial Model: N/A
To: FCC Part 15 Subpart B Class B: 2013 , ANSI C63.4:2009

Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 31 of 36
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Annex C. TEST SETUP AND SUPPORTING EQUIPMENT

EUT TEST CONDITIONS

Annex C. i. SUPPORTING EQUIPMENT DESCRIPTION

The following is a description of supporting equipment and details of cables used with the EUT.

Equipment Description (Including Brand Name)	Model & Serial Number	Cable Description (List Length, Type & Purpose)
Lenovo Laptop	E40& 0579A52	N/A



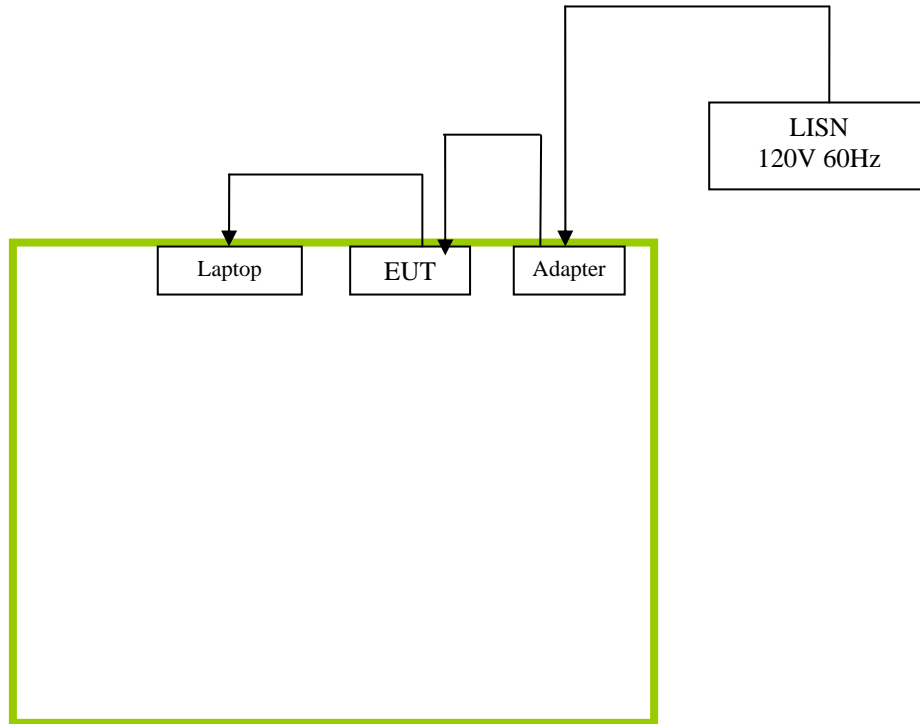
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Main Model: s4510
Serial Model: N/A
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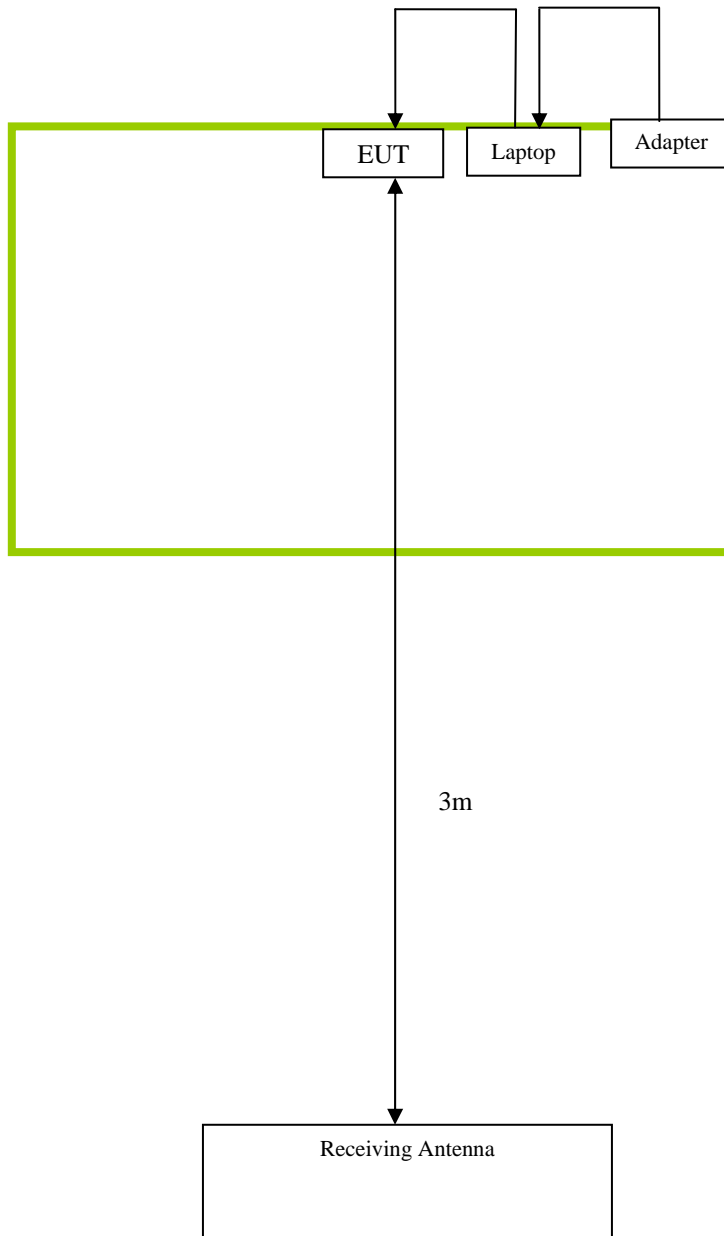
Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 32 of 36
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Block Configuration Diagram for Conducted Emissions Mode: Charging & Downloading





Block Configuration Diagram for Radiated Emissions Mode: Charging & Downloading





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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 34 of 36
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Annex C.ii. EUT OPERATING CONDITIONS

The following is the description of how the EUT is exercised during testing.

Test	Description Of Operation
Emissions	Charging & Downloading



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Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 35 of 36
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Annex D. USER MANUAL / BLOCK DIAGRAM / SCHEMATICS / PART LIST

Please see attachment



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To: FCC Part 15 Subpart B Class B: 2013 , ANSI C63.4:2009

Report No.: 14070326-FCC-E1
Issue Date: July 18, 2014
Page: 36 of 36
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Annex E. DECLARATION OF SIMILARITY